

Notice of References Cited	Application/Control No. 10/586,682		Applicant(s)/Patent Under Reexamination LEYRER ET AL.	
	Examiner HUI CHIN		Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0090611	04-2005	Huffer et al.	524/800
*	B	US-2004/0171759	09-2004	Lange et al.	525/192
*	C	US-2003/0225168	12-2003	Deroo et al.	516/77
*	D	US-6,677,293	01-2004	Allgaier et al.	510/417
*	E	US-2003/0129151	07-2003	Candau et al.	424/59
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.